HEF4047B

Monostable/astable multivibrator

Rev. 5 — 16 December 2015

Product data sheet

1. General description

The HEF4047B consists of a gatable astable multivibrator incorporating logic techniques to permit positive or negative edge-triggered monostable multivibrator action with retriggering and external counting options.

Inputs include +TRIGGER, -TRIGGER, ASTABLE, ASTABLE, RETRIGGER and MR (master reset). Buffered outputs are O, \overline{O} and OSCILLATOR OUTPUT. In all modes of operation an external capacitor (C_t) must be connected between CTC and RCTC, and an external resistor (R_t) must be connected between RTC and RCTC.

A HIGH level on the ASTABLE input enables a stable operation. The period of the square wave at O and \overline{O} outputs is a function of the external components employed. 'True' input pulses on the ASTABLE or 'complement' pulses on the $\overline{ASTABLE}$ input, allow the circuit to be used as a gatable multivibrator. The OSCILLATOR OUTPUT period is half of the O output in the astable mode. However, a 50% duty factor is not guaranteed at this output.

In the monostable mode, positive edge-triggering is accomplished by applying a leading-edge pulse to the +TRIGGER input and a LOW level to the -TRIGGER input. For negative edge-triggering, a trailing-edge pulse is applied to the -TRIGGER and a HIGH level to the +TRIGGER. Input pulses may be of any duration relative to the output pulse. The multivibrator can be retriggered (on the leading-edge only) by applying a common pulse to both the RETRIGGER and +TRIGGER inputs. In this mode, the output pulse remains HIGH as long as the input pulse period is shorter than the period determined by the RC components.

An external count down option implements coupling O to an external 'N' counter and resetting the counter with the trigger pulse. The counter output pulse is fed back to the $\overline{\mathsf{ASTABLE}}$ input and has a duration equal to N times the period of the multivibrator. A HIGH level on the MR input assures no output pulse during an ON-power condition. This input can also be activated to terminate the output pulse at any time. In the monostable mode, a HIGH level or power-ON reset pulse must be applied to MR, whenever V_{DD} is applied.

2. Features and benefits

2.1 General

- Monostable (one-shot) or a stable (free-running) operation
- True and complemented buffered outputs
- Only one external resistor and capacitor required



2.2 Monostable multivibrator

- Positive- or negative-edge triggering
- Output pulse width independent of trigger pulse duration
- Retriggerable option for pulse-width expansion
- Long pulse width possible using small RC components with external counter provision
- Fast recovery time independent of pulse width
- Pulse-width accuracy maintained at duty cycles approaching 100%

2.3 Astable multivibrator

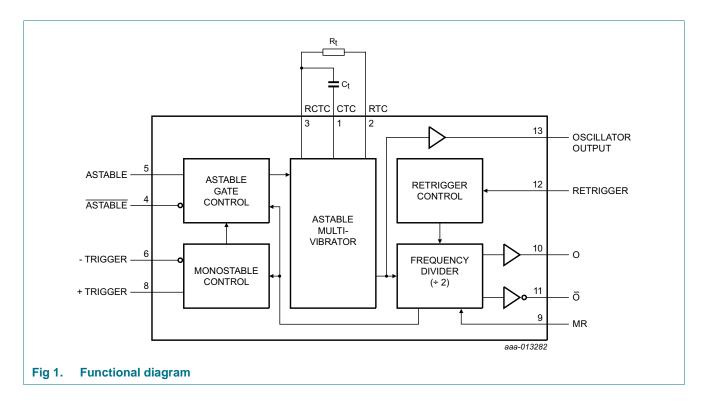
- Free-running or gatable operating modes
- 50% duty cycle
- Oscillator output available

3. Ordering information

Table 1. Ordering information

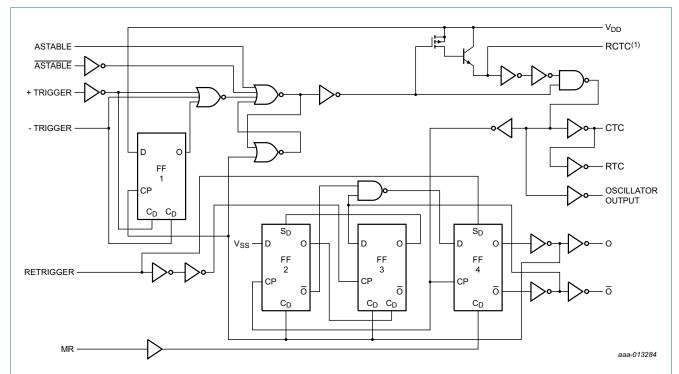
Type number	Package	ackage					
	Name	Description	Version				
HEF4047BT	SO14	plastic small outline package; 14 leads; body width 3.9 mm	SOT108-1				

4. Functional diagram



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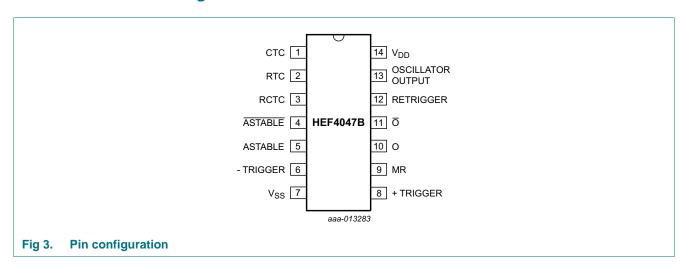


(1) Special input protection that allows operating input voltages outside the supply voltage lines. Compared to the standard input protection pin 3 (RCTC) is more sensitive to static discharge; extra handling precautions are recommended.

Fig 2. Logic diagram

5. Pinning information

5.1 Pinning



5.2 Pin description

Table 2. Pin description

Symbol	Pin	Description
СТС	1	external capacitor connection
RTC	2	external resistor connection
RCTC	3	external capacitor/resistor connection
ASTABLE	4	input
ASTABLE	5	input
-TRIGGER	6	input
V _{SS}	7	ground supply voltage
+TRIGGER	8	input
MR	9	master reset input
0	10	output
ō	11	output
RETRIGGER	12	input
OSCILLATOR OUTPUT	13	oscillator output
V_{DD}	14	supply voltage

6. Limiting values

Table 3. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134).

Symbol	Parameter	Conditions	Min	Max	Unit
V_{DD}	supply voltage		-0.5	+18	V
I _{IK}	input clamping current	$V_{I} < -0.5 \text{ V or } V_{I} > V_{DD} + 0.5 \text{ V}$	-	±10	mA
VI	input voltage		-0.5	V _{DD} + 0.5	V
I _{OK}	output clamping current	$V_{O} < -0.5 \text{ V or } V_{O} > V_{DD} + 0.5 \text{ V}$	-	±10	mA
I _{I/O}	input/output current		-	±10	mA
I _{DD}	supply current		-	50	mA
T _{stg}	storage temperature		-65	+150	°C
T _{amb}	ambient temperature		-40	+85	°C
P _{tot}	total power dissipation	$T_{amb} = -40 ^{\circ}\text{C} \text{ to } +85 ^{\circ}\text{C}$			
		SO14 package [1]	-	500	mW
Р	power dissipation	per output	-	100	mW

^[1] For SO14 package: P_{tot} derates linearly with 8 mW/K above 70 $^{\circ}\text{C}.$

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7. Recommended operating conditions

Table 4. Operating conditions

Symbol	Parameter	Conditions	Min	Max	Unit
V_{DD}	supply voltage		3	15	V
VI	input voltage		0	V_{DD}	V
T _{amb}	ambient temperature	in free air	-40	+85	°C
Δt/ΔV	input transition rise and fall	V _{DD} = 5 V	-	3.75	μs/V
	rate	V _{DD} = 10 V	-	0.5	μs/V
		V _{DD} = 15 V	-	0.08	μs/V

8. Static characteristics

Table 5. Static characteristics

 $V_{SS} = 0$ V; $V_I = V_{SS}$ or V_{DD} unless otherwise specified.

Symbol	Parameter	Conditions	V_{DD}	T _{amb} =	–40 °C	T _{amb} =	25 °C	T _{amb} =	85 °C	Unit
				Min	Max	Min	Max	Min	Max	
V _{IH}	HIGH-level input voltage	I _O < 1 μA	5 V	3.5	-	3.5	-	3.5	-	V
			10 V	7.0	-	7.0	-	7.0	-	V
			15 V	11.0	-	11.0	-	11.0	-	V
V _{IL}	LOW-level input voltage	I _O < 1 μA	5 V	-	1.5	-	1.5	-	1.5	V
			10 V	-	3.0	-	3.0	-	3.0	V
			15 V	-	4.0	-	4.0	-	4.0	V
V _{OH}	HIGH-level output voltage	I _O < 1 μA	5 V	4.95	-	4.95	-	4.95	-	V
			10 V	9.95	-	9.95	-	9.95	-	V
			15 V	14.95	-	14.95	-	14.95	-	V
V_{OL}	LOW-level output voltage	I _O < 1 μA	5 V	-	0.05	-	0.05	-	0.05	V
			10 V	-	0.05	-	0.05	-	0.05	V
			15 V	-	0.05	-	0.05	-	0.05	V
I _{OH}	HIGH-level output current	V _O = 2.5 V	5 V	-	-1.7	-	-1.4	-	-1.1	mA
		V _O = 4.6 V	5 V	-	-0.52	-	-0.44	-	-0.36	mA
		V _O = 9.5 V	10 V	-	-1.3	-	-1.1	-	-0.9	mA
		V _O = 13.5 V	15 V	-	-3.6	-	-3.0	-	-2.4	mA
I _{OL}	LOW-level output current	V _O = 0.4 V	5 V	0.52	-	0.44	-	0.36	-	mA
		V _O = 0.5 V	10 V	1.3	-	1.1	-	0.9	-	mA
		V _O = 1.5 V	15 V	3.6	-	3.0	-	2.4	-	mA
I _I	input leakage current		15 V	-	±0.3	-	±0.3	-	±1.0	μА
		output transistor OFF; pin 3 at V _{DD} or V _{SS}	15 V	-	±0.3	-	±0.3	-	±1.0	μΑ
I _{DD}	supply current	I _O = 0 A	5 V	-	20	-	20	-	150	μΑ
			10 V	-	40	-	40	-	300	μА
			15 V	-	80	-	80	-	600	μА
Cı	input capacitance		-	-	-	-	7.5	-	-	pF

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9. Dynamic characteristics

Table 6. Dynamic characteristics

 $V_{SS} = 0 \text{ V}$; $T_{amb} = 25 \text{ °C}$; for test circuit and waveform, see <u>Figure 4</u> and <u>Figure 5</u>; unless otherwise specified.

Symbol	Parameter	Conditions	V_{DD}		Extrapolation formula	Min	Тур	Max	Unit
t _{PHL}	HIGH to LOW	ASTABLE, ASTABLE	5 V	[1]	68 ns + (0.55 ns/pF)C _L	-	95	190	ns
	propagation delay	to OSCILLATOR OUTPUT	10 V	[1]	43 ns + (0.23 ns/pF)C _L	-	45	90	ns
		OUTFUT	15 V	[1]	22 ns + (0.16 ns/pF)C _L	-	30	60	ns
t _{PLH}	LOW to HIGH	ASTABLE, ASTABLE	5 V	[1]	58 ns + (0.55 ns/pF)C _L	-	85	170	ns
	propagation delay	to OSCILLATOR OUTPUT	10 V		29 ns + (0.23 ns/pF)C _L	-	40	80	ns
		OUTFUT	15 V		22 ns + (0.16 ns/pF)C _L	-	30	60	ns
t _{PHL}	HIGH to LOW	ASTABLE, ASTABLE	5 V	[1]	123 ns + (0.55 ns/pF)C _L	-	150	300	ns
	propagation delay	to O, O	10 V		54 ns + (0.23 ns/pF)C _L	-	65	130	ns
			15 V		42 ns + (0.16 ns/pF)C _L	-	50	100	ns
t _{PLH}	LOW to HIGH	ASTABLE, ASTABLE	5 V	[1]	103 ns + (0.55 ns/pF)C _L	-	130	260	ns
	propagation delay	to O, O	10 V		49 ns + (0.23 ns/pF)C _L	-	60	120	ns
			15 V		37 ns + (0.16 ns/pF)C _L	-	45	90	ns
t _{PHL}	HIGH to LOW	+/-TRIGGER to O, O	5 V	[1]	133 ns + (0.55 ns/pF)C _L	-	160	320	ns
	propagation delay		10 V		54 ns + (0.23 ns/pF)C _L	-	65	130	ns
			15 V		42 ns + (0.16 ns/pF)C _L	-	50	100	ns
t _{PLH}	LOW to HIGH	+/-TRIGGER to O, O	5 V	[1]	128 ns + (0.55 ns/pF)C _L	-	155	310	ns
	propagation delay		10 V		54 ns + (0.23 ns/pF)C _L	-	65	130	ns
			15 V		42 ns + (0.16 ns/pF)C _L	-	50	100	ns
t _{PHL}	HIGH to LOW	+TRIGGER,	5 V	[1]	38 ns + (0.55 ns/pF)C _L	-	65	130	ns
	propagation delay	RETRIGGER to O	10 V		19 ns + (0.23 ns/pF)C _L	-	30	60	ns
			15 V		17 ns + (0.16 ns/pF)C _L	-	25	50	ns
t _{PLH}	LOW to HIGH	+TRIGGER,	5 V	[1]	68 ns + (0.55 ns/pF)C _L	-	95	190	ns
	propagation delay	RETRIGGER to O	10 V		29 ns + (0.23 ns/pF)C _L	-	40	80	ns
			15 V		22 ns + (0.16 ns/pF)C _L	-	30	60	ns
t _{PHL}	HIGH to LOW	MR to O	5 V	[1]	83 ns + (0.55 ns/pF)C _L	-	100	200	ns
	propagation delay		10 V		34 ns + (0.23 ns/pF)C _L	-	45	90	ns
			15 V		27 ns + (0.16 ns/pF)C _L	-	35	70	ns
t _{PLH}	LOW to HIGH	MR to \overline{O}	5 V	[1]	83 ns + (0.55 ns/pF)C _L	-	100	200	ns
	propagation delay		10 V		34 ns + (0.23 ns/pF)C _L	-	45	90	ns
			15 V		27 ns + (0.16 ns/pF)C _L	-	35	70	ns
t _{THL}	HIGH to LOW		5 V	[1]	10 ns + (1.0 ns/pF)C _L	-	60	120	ns
	output transition time		10 V		9 ns + (0.42 ns/pF)C _L	-	30	60	ns
	ume		15 V		6 ns + (0.28 ns/pF)C _L	-	20	40	ns
t _{TLH}	LOW to HIGH		5 V	[1]	10 ns + (1.0 ns/pF)C _L	-	60	120	ns
	output transition		10 V		9 ns + (0.42 ns/pF)C _L	-	30	60	ns
	time		15 V		6 ns + (0.28 ns/pF)C _L	-	20	40	ns

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 Table 6.
 Dynamic characteristics ...continued

 $V_{SS} = 0 \text{ V}$; $T_{amb} = 25 \text{ °C}$; for test circuit and waveform, see <u>Figure 4</u> and <u>Figure 5</u>; unless otherwise specified.

Symbol	Parameter	Conditions	V_{DD}	Extrapolation formula	Min	Тур	Max	Unit
t _W	pulse width	any input except MR	5 V	-	220	110	-	ns
			10 V	-	100	50	-	ns
			15 V	-	70	35	-	ns
		MR HIGH	5 V	-	60	30	-	ns
			10 V	-	30	15	-	ns
			15 V	-	20	10	-	ns

^[1] The typical values of the propagation delay and transition times are calculated from the extrapolation formulas shown (C_L in pF).

10. Waveforms

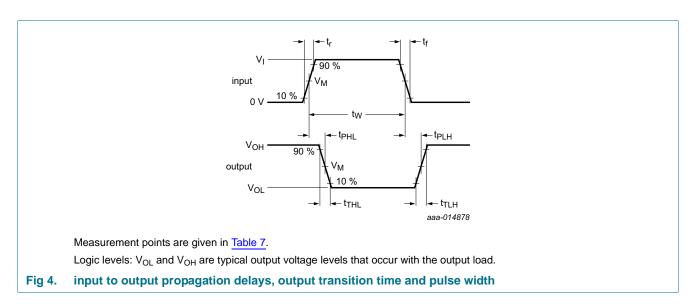
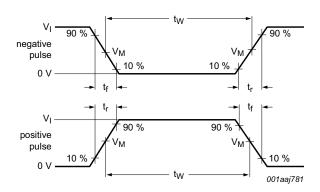


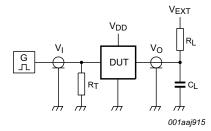
Table 7. Measurement points

Supply voltage	Input	Output
V_{DD}	V _M	V _M
5 V to 15 V	0.5V _{DD}	0.5V _{DD}

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a. Input waveform



b. Test circuit

Test and measurement data is given in Table 8.

Definitions test circuit:

DUT = Device Under Test.

 R_T = Termination resistance should be equal to output impedance Z_o of the pulse generator.

 C_L = Load capacitance including jig and probe capacitance.

Fig 5. Test circuit for measuring switching times

Table 8. Test data

Supply voltage	Input		Load	Load		
	VI	t _r , t _f	C _L	R _L	t _{PLH} , t _{PHL}	
5 V to 15 V	V_{DD}	≤ 20 ns	50 pF	1 kΩ	open	

11. Application information

Table 9. Functional connections [1]

Function	F	Pins connected to		Output pulse from	Output period or
	V_{DD}	V _{SS}	input pulse	pins	pulse width
Astable multivibrator					
Free running	4, 5, 6, 14	7, 8, 9, 12	-	10, 11, 13	at pins 10, 11;
True gating	4, 6, 14	7, 8, 9, 12	5	10, 11, 13	$t_A = 4.40 R_t C_t$ at pin 13:
Complement gating	6, 14	5, 7, 8, 9, 12	4	10, 11, 13	$t_A = 2.20 R_t C_t$

Table 9.	Functional	connections	continued[1]
Table 3.	i uncuonai	COHINECTIONS	comunueu

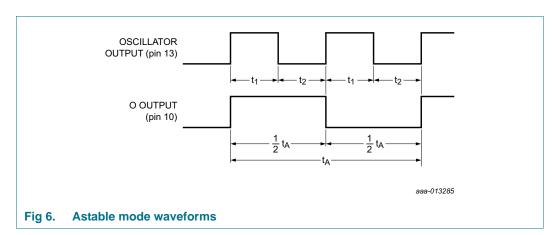
Function		Pins connected to Output pulse from		Pins connected to		Output period or
	V _{DD}	V _{SS}	input pulse	pins	pulse width	
Monostable multivibrator						
Positive edge-triggering	4, 14	5, 6, 7, 9, 12	8	10, 11	at pins 10, 11;	
Negative edge-triggering	4, 8, 14	5, 7, 9, 12	6	10, 11	$t_{\rm M} = 2.48 \; R_{\rm t} C_{\rm t}$	
Retriggerable	4, 14	5, 6, 7, 9	8, 12	10, 11		
External countdown[2]	14	5, 6, 7, 8, 9, 12	-	10, 11		

- [1] In all cases, external resistor between pins 2 and 3, external capacitor between pins 1 and 3.
- [2] Input pulse to RESET of external counting chip: external counting chip output to pin 4.

11.1 Astable mode design information

11.1.1 Unit-to-unit transfer voltage variations

The following analysis presents worst case variations from unit-to-unit as a function of transfer voltage (V_{TR}) shift for free running (astable) operation.



$$t_I = -R_t C_t \ln \frac{V_{TR}}{V_{DD} + V_{TR}} \tag{1}$$

$$t_2 = -R_t C_t \ln \frac{V_{DD} - V_{TR}}{2V_{DD} - V_{TR}} \tag{2}$$

$$t_A = 2(t_1 + t_2) = -2R_t C_t \ln \frac{(V_{TR})(V_{DD} - V_{TR})}{(V_{DD} + V_{TR})(2V_{DD} - V_{TR})}$$
(3)

, where t_A = astable mode pulse width; see <u>Table 10</u>.

Table 10. Values for a table mode pulse width (t_A)

	V_{TR}			t _A		
	Min	Тур	Max	Min	Typ[1]	Max
V _{DD} = 5 V or 10 V	$0.3 \times V_{DD}$	$0.5 \times V_{DD}$	$0.7 \times V_{DD}$	4.71 R _t C _t	4.40 R _t C _t	4.71 R _t C _t
V _{DD} = 15 V	4 V	$0.5 \times V_{DD}$	11 V	4.84 R _t C _t	4.40 R _t C _t	4.84 R _t C _t

[1] Therefore if t_A = 4.40 R_tC_t is used, the maximum variation is (+7.0%; -0.0%) at 10 V.

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11.1.2 Variations due to changes in V_{DD}

In addition to variations from unit-to-unit, the astable period may vary as a function of frequency with respect to V_{DD} . Typical variations are presented graphically in <u>Figure 7</u> and Figure 8 with 10 V as a reference.

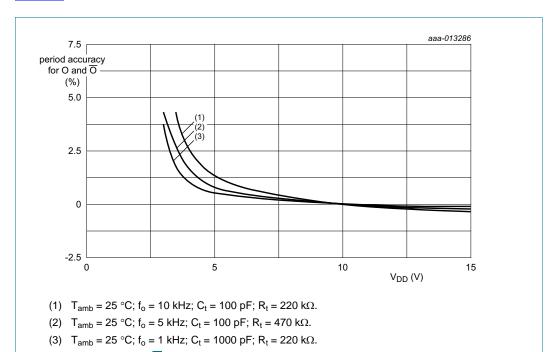
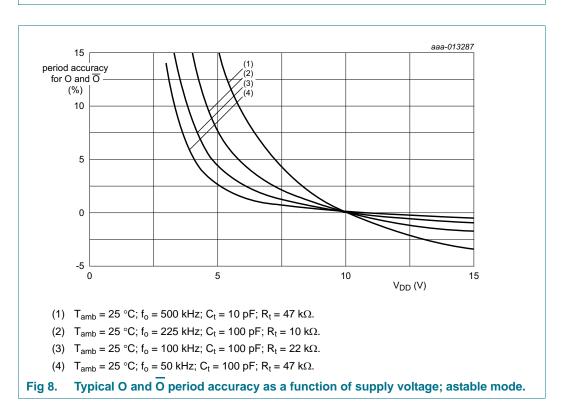
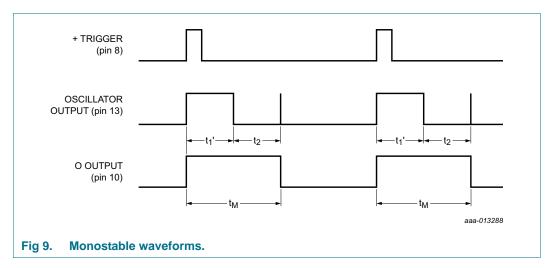


Fig 7. Typical O and O period accuracy as a function of supply voltage; astable mode.



11.2 Monostable mode design information

The following analysis presents worst case variations from unit-to-unit as a function of transfer voltage (V_{TR}) shift for one-shot (monostable) operation.



$$t_I' = -R_t C_t \ln \frac{V_{TR}}{2V_{DD}} \tag{4}$$

$$t_M = (t_1' + t_2)$$
 (5)

$$t_{M} = -R_{t}C_{t} \ln \frac{(V_{TR})(V_{DD} - V_{TR})}{(2V_{DD} - V_{TR})(2V_{DD})}$$
(6)

, where t_M = monostable mode pulse width; see table <u>Table 11</u>.

Table 11. Values for monostable mode pulse width (t_M)

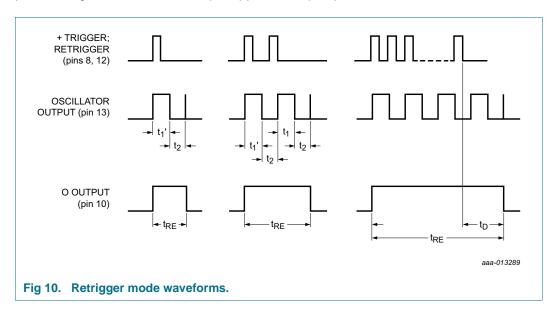
	V _{TR}			t _M		
	Min	Тур	Max	Min	Typ[1]	Max
V _{DD} = 5 V or 10 V	$0.3 \times V_{DD}$	$0.5 \times V_{DD}$	$0.7 \times V_{DD}$	2.78 R _t C _t	2.48 R _t C _t	2.52 R _t C _t
V _{DD} = 15 V	4 V	$0.5 \times V_{DD}$	11 V	2.88 R _t C _t	2.48 R _t C _t	2.56 R _t C _t

[1] In the astable mode, the first positive half cycle has a duration of t_M : succeeding durations are $\frac{1}{2}t_A$. Therefore if t_M = 2.48 R_tC_t is used, the maximum variation is (+12%; -0.0%) at 10 V.

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11.2.1 Retrigger mode operation

The HEF4047B can be used in the retrigger mode to extend the output pulse duration. It can also be used to compare the frequency of an input signal with the frequency of the internal oscillator. In the retrigger mode, the input pulse is applied to pins 8 and 12, and the output is taken from pin 10 or 11. Normal monostable action is obtained when one retrigger pulse is applied (see <u>Figure 10</u>). Extended pulse duration is obtained when more than one pulse is applied. For two input pulses, $t_{RE} = t_1' + t_1 + 2t_2$. For more than two pulses, t_{RE} (output O), terminates at some variable time, t_D , after the termination of the last retrigger pulse. t_D is variable because t_{RE} (output O) terminates after the second positive edge of the oscillator output appears at flip-flop 4.



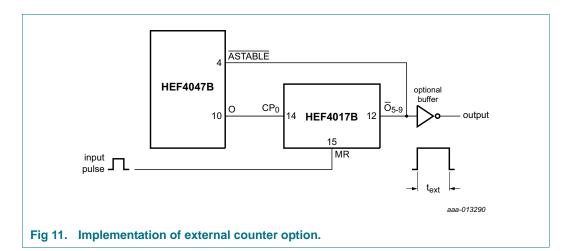
11.2.2 External counter option

The use of external counting circuitry extends time t_M by any amount. Advantages include digitally controlled pulse duration, small timing capacitors for long time periods, and extremely fast recovery time. A typical implementation is shown in Figure 11.

The pulse duration at the output is:

$$t_{ext} = (N-1)(t_A) + (t_M + 1/2 t_A)$$
(7)

Where t_{ext} = pulse duration of the circuitry, and N is the number of counts used.



11.2.3 Timing component limitations

The capacitor used in the circuit should be non-polarized and have low leakage (that is the parallel resistance of the capacitor should be an order of magnitude greater than the external resistor used). There is no upper or lower limit for either R_t or C_t value to maintain oscillation. However, for accuracy, C_t must be much larger than the inherent stray capacitance in the system (unless this capacitance can be measured and taken into account). R_t must be much larger than the LOCMOS 'ON' resistance in series with it, which typically is hundreds of ohms.

The recommended values for R_t and C_t to comply with previously calculated formulae without trimming should be:

- $C_t \ge 100$ pF, up to any practical value
- 10 $k\Omega \le R_t \le 1$ $M\Omega$

11.2.4 Power consumption

In the standby mode (monostable or astable), power dissipation is a function of leakage current in the circuit. For dynamic operation, the power required to charge the external timing capacitor C_t is shown in the following formulae:

Astable mode:

$$P = 2 C_t V^2 f \qquad (f \text{ at output pin } 13)$$
(8)

$$P = 4 C_t V^2 f \qquad (f \text{ at output pins } 10 \text{ and } 11)$$
 (9)

Monostable mode:

$$P = \frac{(2.9 \text{ C}_t \text{ V}^2)(\text{duty cycle})}{T} \qquad \text{(f at output pins 10 and 11)}$$

Because the power dissipation does not depend on R_t , a design for minimum power dissipation would be a small value of C_t . The value of R would depend on the desired period (within the limitations discussed previously). Typical power consumption in astable mode is shown in Figure 12, Figure 13 and Figure 14.

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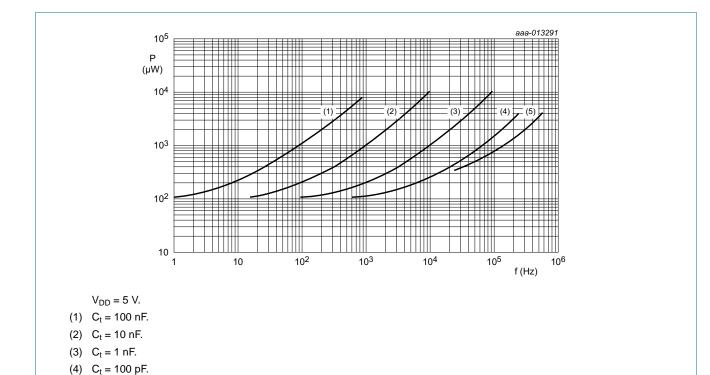
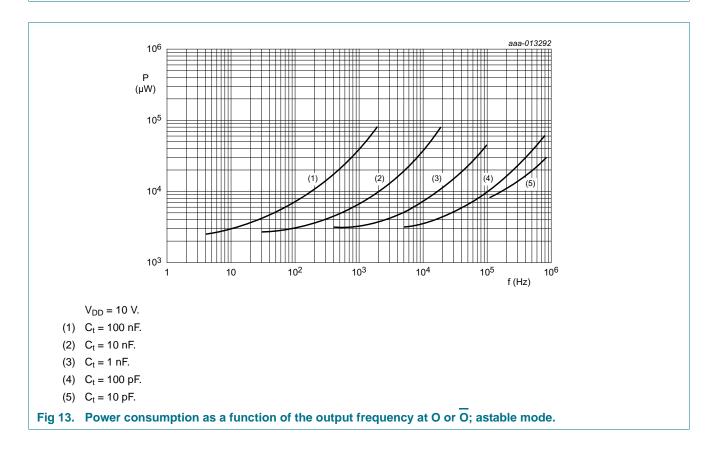
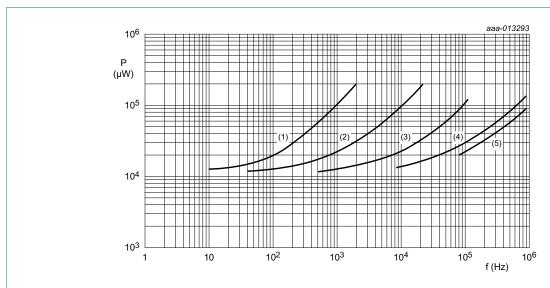


Fig 12. Power consumption as a function of the output frequency at O or \overline{O} ; astable mode.



(5) $C_t = 10 \text{ pF}.$

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 $V_{DD} = 15 \text{ V}.$

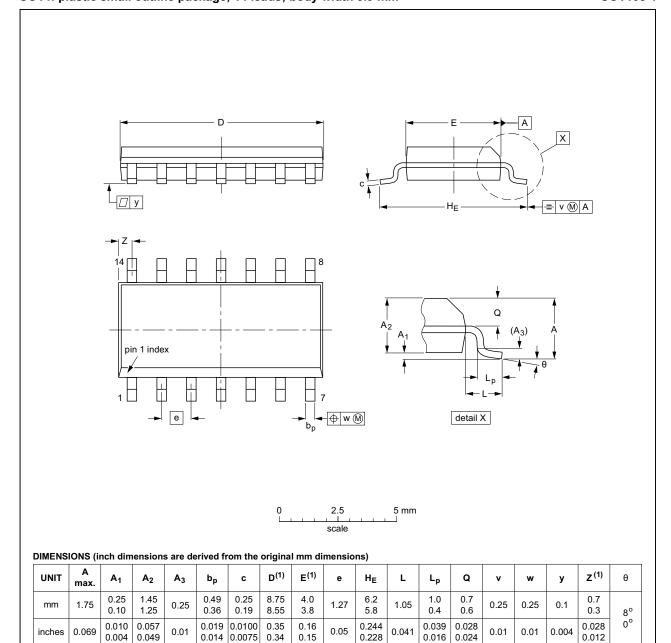
- (1) $C_t = 100 \text{ nF}.$
- (2) $C_t = 10 \text{ nF}.$
- (3) $C_t = 1 \text{ nF}.$
- (4) $C_t = 100 \text{ pF}.$
- (5) $C_t = 10 \text{ pF}.$

Fig 14. Power consumption as a function of the output frequency at O or \overline{O} ; astable mode.

12. Package outline

SO14: plastic small outline package; 14 leads; body width 3.9 mm

SOT108-1



Note

1. Plastic or metal protrusions of 0.15 mm (0.006 inch) maximum per side are not included.

OUTLINE	REFERENCES				EUROPEAN	ISSUE DATE
VERSION	IEC	JEDEC	JEITA		PROJECTION	ISSUE DATE
SOT108-1	076E06	MS-012				99-12-27 03-02-19

Fig 15. Package outline SOT108-1 (SO14)

HEF4047E

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Monostable/astable multivibrator

13. Abbreviations

Table 12. Abbreviations

Acronym	Description
DUT	Device Under Test

14. Revision history

Table 13. Revision history

Document ID	Release date	Data sheet status	Change notice	Supersedes	
HEF4047B v.5	20151216	Product data sheet	-	HEF4047B v.4	
Modifications:	Type number HEF4047BP (SOT27-1) removed.				
HEF4047B v.4	20140915	Product data sheet	-	HEF4047B_CVN_3	
Modifications:	 The format of this data sheet has been redesigned to comply with the new identity guidelines of NXP Semiconductors. 				
	 Legal texts have been adapted to the new company name where appropriate. 				
HEF4047B_CVN_3	19950101	Product specification	-	-	

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Document status[1][2]	Product status[3]	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
Preliminary [short] data sheet	Qualification	This document contains data from the preliminary specification.
Product [short] data sheet	Production	This document contains the product specification.

- [1] Please consult the most recently issued document before initiating or completing a design.
- [2] The term 'short data sheet' is explained in section "Definitions"
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Product data sheet

NXP Semiconductors



Monostable/astable multivibrator

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